

| Form PTO 1449 (Modified) | | U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE | | ATTY DOCKET NO. 0057-2362-2YY | | SERIAL NO. 09/176,315 | |
|---|----|---|----------|--------------------------------------|--------------------------------|--------------------------|-------------------------------|
| <div style="border: 2px solid black; border-radius: 50%; padding: 10px; display: inline-block;"> COIPE MAR 05 2003 PATENT & TRADEMARK OFFICE </div> LIST OF REFERENCES CITED BY APPLICANT | | | | APPLICANT SHIGENOBU MAEDA, ET AL. | | | |
| | | | | FILED OCTOBER 22, 1998 | | GROUP 2811 | |
| U.S. PATENT DOCUMENTS | | | | | | | |
| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUB CLASS | FILING DATE IF APPROPRIATE |
| SWC | AA | 4,946,799 | 08/07/90 | Blake et al. | | | |
| | AB | | | | | | |
| | AC | | | | | | |
| | AD | | | | | | |
| | AE | | | | | | |
| | AF | | | | | | |
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| FOREIGN PATENT DOCUMENTS | | | | | | | |
| | | DOCUMENT NUMBER | DATE | COUNTRY | TRANSLATION YES NO | | |
| SWC | AP | DE 196 23 846 A1 | 04/17/97 | Germany | | x | |
| | AQ | DE 44 41 901 A1 | 05/30/98 | Germany | | x | |
| | AR | | | | | | |
| | AS | | | | | | |
| | AT | | | | | | |
| | AU | | | | | | |
| | AV | | | | | | |
| | AW | | | | | | |
| OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.) | | | | | | | |
| | AX | Modulationsdotierte Feldeffekttransistoren; Heiner HeiB; Dissertaton am Lehrstuhl für Halbleitertechnologie der TU München; eingereicht am 31.10.1996, pages 59 to 69 (with English abstract) | | | | | |
| | AY | Schumicki, Seegebrect; Prozesstechnologie; paes 404 to 436; ; Springer Verlag; 1991 (with English abstract) | | | | | |
| | AZ | | | | | | |
| | AZ | | | | | | |
| Examiner CRANE | | | | | Date Considered 4/28/03 | | |
| <small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small> | | | | | | | |